IDC	Form	DTO/CD/08-	Substitute for form	1440A/PTC
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet	1	of	1

	Complete if Known	3 %,
Application Number	10/574,583	13 3
Filing Date	February 8, 2007	193
First Named Inventor	Sayoko MATSUMOTO	et al.
Art Unit	1645	WARK C
Examiner Name	Unknown	
Attorney Docket Number	09812.0126	

Examiner Initials	Cite No. ¹	Document Number	Issue or	- Fr	Pages, Columns, Lines, Where Relevant Passages or Relevan Figures Appear	
		At all all all Card Card Card Card	Publication Date MM-DD-YYYY			
		US-6,203,683	03/20/2001	Austin et al.		
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Note: Copies of the U.S. Patent Documents are not Required in IDS filed after October 21, 2004

		FORE	GN PATENT	DOCUMENTS			
Examiner Initials	Cite No. ¹	Foreign Patent Document Country Code ³ Number ⁴ Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁶	
		JP-08-322569	12-10-1996	SHIMADZU CORP.		English Abstract	
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		Supplementary European Search Report dated November 11, 2007.					
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Examiner	Date	
Signature	Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.